

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
LEE, BAEK-WOON

Examiner

MY-CHAU T. TRAN

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,833,888 B2	12-2004	Song et al.	349/106
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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